	Application No.	Applicant(s)	
Notice of Allowability	10/813,570	YUE et al.	
	Examiner	Art Unit	
	Lee, Calvin	2825	
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308. 1. This communication is responsive to Telephone Interview dated 1/6/05.			
1. \(\sum \) This communication is responsive to \(Telephone Interview \).	<u>dated 1/6/05</u> .		
2. ☑ The allowed claim(s) is/are <u>1-17</u> .			
.3. The drawings filed on 31 March 2004 are accepted by the Examiner.			
 4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some* c) None of the: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 			
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.			
5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.			
6. CORRECTED DRAWINGS (as "replacement sheets") must (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in the second paper No./Mail Date	son's Patent Drawing Review(PTO s Amendment / Comment or in the C .84(c)) should be written on the drawin	Office action of ngs in the front (not the back) of	
7. DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT	sit of BIOLOGICAL MATERIAL I FOR THE DEPOSIT OF BIOLOGIC	nust be submitted. Note the AL MATERIAL.	
 Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/O Paper No./Mail Date	6. ⊠ Interview Summary Paper No./Mail Da 08), 7. ⊠ Examiner's Amenda	te <i>hereto</i> .	

Application No: 10/813,570

Docket: 071469-0308624

OFFICE ACTION

Examiner's Amendment

An examiner's amendment to the record appears below. Should the changes and/or additions 1. be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312

CLAIMS:

- (1S): Canceled claims 18-20.

 In claim 13, line 1, delete "form" and replace with-from --.

 Authorization for this examiner's amendment was given in a telephone interview with 2. Jeffrey D. Karceski on January 6, 2005. [The handwritten change was noted, and is done to correct a typographical error Allowable Subject Matter
- 3. Claims 1-17 are allowed. Following is the statement reason for allowance:

The closest prior art, US 6,716,570 to Nagarajan et al discloses forming a pattern in a second layer 18 having a first critical dimension L1 [Fig. 1a], and transferring the pattern from the second layer to a first layer 16 having a second critical dimension L2 [Fig. 1c and col. 6]. US 6,235,609 to Sengupta et al discloses forming a pattern in a second layer 240 having a first critical dimension [Fig. 2B], and transferring the pattern from the second layer to a first layer 230 having a second critical dimension [Fig. 2E and col. 4]. None of the cited arts teaches or suggests, inter alia, setting a target trim amount for reducing a first critical dimension to a second critical dimension and determining a variable parameter for a process recipe using the target trim amount and a process model relating trim amount data to the variable parameter.

Any comments considered necessary by applicant must be submitted no later than the 4. payment of the issue fee and, to avoid delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance.

Any inquiry concerning this communication from the Examiner should be directed to Calvin Lee at (571) 272-1896 from 7:00 to 5:00 (Mo-Th). If attempts to reach the examiner are unsuccessful, Art Unit 2825's Supervisory Patent Examiner Matthew Smith can be reached at (571) 272-1907.

Any inquiry relating to the status of this application should be directed to the Group receptionist whose telephone number is (703) 308-0596. The central fax number is (703) 872-9306 for all communications to be entered (e.g., amendments, remarks, IDS, etc.)

January 6, 2005

SUPERVISORY PATENT EXAMINER **TECHNOLOGY CENTER 2800**